SDAS192B - APRIL 1982 - REVISED DECEMBER 1994

 Package Options Include Plastic Small-Outline (D) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

description

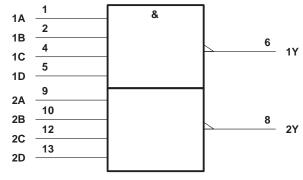
These devices contain two independent 4-input positive-NAND gates. They perform the Boolean functions $Y = \overline{A} \cdot \overline{B} \cdot \overline{C} \cdot \overline{D}$ or $Y = \overline{A} + \overline{B} + \overline{C} + \overline{D}$ in positive logic.

The SN54ALS20A and SN54AS20 are characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ALS20A and SN74AS20 are characterized for operation from 0°C to 70°C.

FUNCTION TABLE (each gate)

	INP	UTS	OUTPUT	
Α	В	С	D	Y
Н	Н	Н	Н	L
L	Χ	Χ	Χ	Н
X	L	Χ	Χ	Н
Х	Χ	L	Χ	Н
X	X	X	L	Н

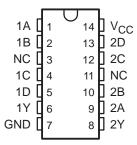
logic symbol†



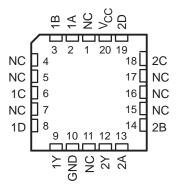
[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for the D, J, and N packages.

SN54ALS20A, SN54AS20 . . . J PACKAGE SN74ALS20A, SN74AS20 . . . D OR N PACKAGE (TOP VIEW)

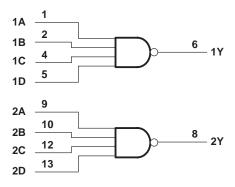


SN54ALS20A, SN54AS20 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

logic diagram (positive logic)



SN54ALS20A, SN54AS20, SN74ALS20A, SN74AS20 DUAL 4-INPUT POSITIVE-NAND GATES

SDAS192B - APRIL 1982 - REVISED DECEMBER 1994

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V _{CC}	7 V
Input voltage, V _I	7 V
Operating free-air temperature range, T _A : SN54ALS20A	55°C to 125°C
SN74ALS20A	0°C to 70°C
Storage temperature range	65°C to 150°C

recommended operating conditions

		SN	54ALS2	0A	SN74ALS20A MIN NOM MAX		UNIT	
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V _{IH}	High-level input voltage	2			2			V
\/	Low-level input voltage			0.8‡			0.8	V
VIL	Low-level input voltage			0.7§				V
IOH	High-level output current			-0.4			-0.4	mA
lOL	Low-level output current			4			8	mA
TA	Operating free-air temperature	-55		125	0		70	°C

[‡] Applies over temperature range -55°C to 70°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CO	MOITIONS	SN	SN54ALS20A		SN74ALS20A			UNIT
PARAMETER	TEST CONDITIONS		MIN	TYP¶	MAX	MIN	TYP¶	MAX	UNII
VIK	V _{CC} = 4.5 V,	I _I = -18 mA			-1.5			-1.5	V
Voн	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -0.4 \text{ mA}$	V _{CC} -2	2		V _{CC} -2	2		V
V _{OL}	V _{CC} = 4.5 V	$I_{OL} = 4 \text{ mA}$		0.25	0.4		0.25	0.4	V
VOL	VCC = 4.5 V	$I_{OL} = 8 \text{ mA}$					0.35	0.5	V
lį	$V_{CC} = 5.5 \text{ V},$	V _I = 7 V			0.1			0.1	mA
lіН	$V_{CC} = 5.5 \text{ V},$	V _I = 2.7 V			20			20	μΑ
Ι _Ι Γ	$V_{CC} = 5.5 \text{ V},$	V _I = 0.4 V			-0.1			-0.1	mA
lo [#]	$V_{CC} = 5.5 \text{ V},$	V _O = 2.25 V	-20		-112	-30		-112	mA
Iссн	$V_{CC} = 5.5 \text{ V},$	V _I = 0		0.22	0.4		0.22	0.4	mA
ICCL	$V_{CC} = 5.5 \text{ V},$	V _I = 4.5 V		0.81	1.5		0.81	1.5	mA

[¶] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.



[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

[§] Applies over temperature range 70°C to 125°C

[#] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

SDAS192B - APRIL 1982 - REVISED DECEMBER 1994

switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _C C _L R _L T _A	UNIT			
			SN54AI MIN	MAX	SN74AI MIN	MAX	
			IVIIIV	INIVV	141114	IVIAA	
^t PLH	A, B, C, or D	\	1	12.5	3	11	ns
^t PHL	A, B, C, 01 B	1	1	11	3	10	119

T For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage, V _{CC}	7 V
Input voltage, V _I	7 V
Operating free-air temperature range, T _A : SN54AS20	
SN74AS20	0°C to 70°C
Storage temperature range	-65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

		S	N54AS2	0	S	N74AS2)	UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
V _{IL}	Low-level input voltage			0.8			0.8	V
IOH	High-level output current			-2			-2	mA
loL	Low-level output current			20			20	mA
TA	Operating free-air temperature	-55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		S	SN54AS20			SN74AS20			
PARAMETER	1231 0	UNDITIONS	MIN	TYP§	MAX	MIN	TYP§	MAX	UNIT	
VIK	$V_{CC} = 4.5 \text{ V},$	$I_{I} = -18 \text{ mA}$			-1.2			-1.2	V	
Voн	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -2 \text{ mA}$	V _{CC} -	2		V _{CC} -2	2		V	
VOL	$V_{CC} = 4.5 V,$	$I_{OL} = 20 \text{ mA}$		0.35	0.5		0.35	0.5	V	
lį	$V_{CC} = 5.5 V,$	V _I = 7 V			0.1			0.1	mA	
liΗ	$V_{CC} = 5.5 V,$	V _I = 2.7 V			20			20	μΑ	
l _{IL}	$V_{CC} = 5.5 \text{ V},$	V _I = 0.4 V			-0.5			-0.5	mA	
ΙΟ [¶]	$V_{CC} = 5.5 \text{ V},$	V _O = 2.25 V	-30		-112	-30		-112	mA	
Іссн	$V_{CC} = 5.5 V,$	V _I = 0		1	1.6		1	1.6	mA	
^I CCL	$V_{CC} = 5.5 V,$	V _I = 4.5 V		5.4	8.7		5.4	8.7	mA	

[§] All typical values are at V_{CC} = 5 V, T_A = 25°C.

The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.



SN54ALS20A, SN54AS20, SN74ALS20A, SN74AS20 DUAL 4-INPUT POSITIVE-NAND GATES

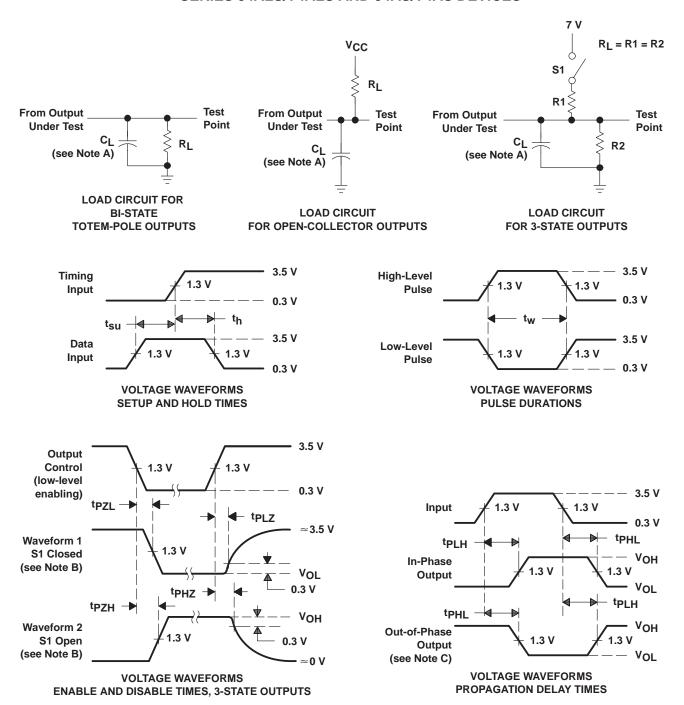
SDAS192B - APRIL 1982 - REVISED DECEMBER 1994

switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _C C _L R _L T _A	UNIT			
			SN54	AS20	SN74/	4520	
			MIN	MAX	MIN	MAX	
^t PLH	A, B, C, or D	V	1	5.5	1	5	ns
[†] PHL	А, Б, С, ОГБ	'	1	5	1	4.5	113

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
- D. All input pulses have the following characteristics: PRR \leq 1 MHz, $t_r = t_f = 2$ ns, duty cycle = 50%.
- E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms



IMPORTANT NOTICE

Texas Instruments and its subsidiaries (TI) reserve the right to make changes to their products or to discontinue any product or service without notice, and advise customers to obtain the latest version of relevant information to verify, before placing orders, that information being relied on is current and complete. All products are sold subject to the terms and conditions of sale supplied at the time of order acknowledgement, including those pertaining to warranty, patent infringement, and limitation of liability.

TI warrants performance of its semiconductor products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

CERTAIN APPLICATIONS USING SEMICONDUCTOR PRODUCTS MAY INVOLVE POTENTIAL RISKS OF DEATH, PERSONAL INJURY, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE ("CRITICAL APPLICATIONS"). TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS. INCLUSION OF TI PRODUCTS IN SUCH APPLICATIONS IS UNDERSTOOD TO BE FULLY AT THE CUSTOMER'S RISK.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards must be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance or customer product design. TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used. TI's publication of information regarding any third party's products or services does not constitute TI's approval, warranty or endorsement thereof.

Copyright © 1998, Texas Instruments Incorporated